

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/734,440	SAMPATH ET AL.	
Examiner	Art Unit	
Shick C. Hom	2616	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (USPT, US-PGPUB) - See search History Printout	6/23/2007	SH
Inventor search - See search printout	6/22/2007	SH
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